SDAS010B - MARCH 1984 - REVISED DECEMBER 1994

 Package Options Include Plastic Small-Outline (D) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

description

These devices contain an 8-input positive-NAND gate and perform the following Boolean functions in positive logic:

$$Y = \overline{A \cdot B \cdot C \cdot D \cdot E \cdot F \cdot G \cdot H}$$

 $Y = \overline{A + B + C + D + E + F + G + H}$

The SN54ALS30A and SN54AS30 characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ALS30A and SN74AS30 are characterized for operation from 0°C to 70°C.

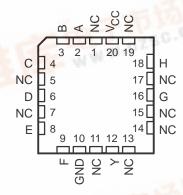
FUNCTION TABLE

| INPUTS A-H | OUTPUT Y |
|----------------------|-------------|
| All inputs H | 0250 |
| One or more inputs L | Н |

SN54ALS30A, SN54AS30 . . . J PACKAGE SN74ALS30A, SN74AS30 . . . D OR N PACKAGE (TOP VIEW)

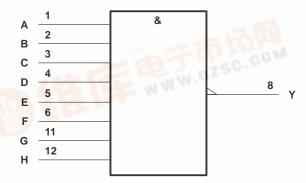


SN54ALS30A, SN54AS30 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

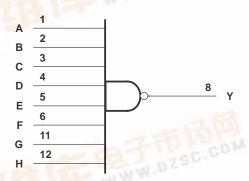
logic symbol†



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for the D, J, and N packages. WWW.DZSC.COM

logic diagram (positive logic)



SN54ALS30A, SN54AS30, SN74ALS30A, SN74AS30 8-INPUT POSITIVE-NAND GATES

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

| Supply voltage, V _{CC} | 7 V |
|---|----------------|
| Input voltage, V _I | 7 V |
| Operating free-air temperature range, T _A : SN54ALS30A | |
| SN74ALS30A | 0°C to 70°C |
| Storage temperature range | -65°C to 150°C |

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

| | | SN54ALS30A | | SN | UNIT | | | |
|-----|--------------------------------|------------|-----|------|------|-----|------|------|
| | | MIN | NOM | MAX | MIN | NOM | MAX | UNIT |
| Vcc | Supply voltage | 4.5 | 5 | 5.5 | 4.5 | 5 | 5.5 | V |
| VIH | High-level input voltage | 2 | | | 2 | | | V |
| ., | Low-level input voltage | | | 0.8‡ | | | 0.8 | V |
| VIL | | | | 0.7§ | | | | V |
| loh | High-level output current | | | -0.4 | | | -0.4 | mA |
| lOL | Low-level output current | | | 4 | | | 8 | mA |
| TA | Operating free-air temperature | -55 | | 125 | 0 | | 70 | °C |

[‡] Applies over temperature range -55°C to 70°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | TEST C | ONDITIONS | SN | 54ALS3 | 0A | SN | UNIT | | |
|-----------------|---|----------------------------|--------------------|--------|------|--------------------|------|------|------|
| PARAMETER | TEST CONDITIONS | | MIN | TYP¶ | MAX | MIN | TYP¶ | MAX | UNII |
| VIK | $V_{CC} = 4.5 \text{ V},$ | $I_{I} = -18 \text{ mA}$ | | | -1.5 | | | -1.5 | V |
| VOH | $V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$ | $I_{OH} = -0.4 \text{ mA}$ | V _{CC} -2 | 2 | | V _{CC} -2 | 2 | | V |
| Va | V _{CC} = 4.5 V | $I_{OL} = 4 \text{ mA}$ | | 0.25 | 0.4 | | 0.25 | 0.4 | V |
| VOL | | $I_{OL} = 8 \text{ mA}$ | | | | | 0.35 | 0.5 | V |
| lį | $V_{CC} = 5.5 \text{ V},$ | V _I = 7 V | | | 0.1 | | | 0.1 | mA |
| lιΗ | $V_{CC} = 5.5 V,$ | V _I = 2.7 V | | | 20 | | | 20 | μΑ |
| IĮL | $V_{CC} = 5.5 \text{ V},$ | V _I = 0.4 V | | | -0.1 | | | -0.1 | mA |
| IO [#] | $V_{CC} = 5.5 \text{ V},$ | V _O = 2.25 V | -20 | | -112 | -30 | | -112 | mA |
| ІССН | $V_{CC} = 5.5 \text{ V},$ | V _I = 0 | | 0.22 | 0.36 | | 0.22 | 0.36 | mA |
| ICCL | $V_{CC} = 5.5 V,$ | V _I = 4.5 V | | 0.54 | 0.9 | | 0.54 | 0.9 | mA |

[¶] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.



[§] Applies over temperature range 70°C to 125°C

[#] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

SN54ALS30A, SN54AS30, SN74ALS30A, SN74AS30 8-INPUT POSITIVE-NAND GATES

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switching characteristics (see Figure 1)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | TO CL = RL = TA = | | V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 500 Ω , T_A = MIN to MAX [†] | | UNIT |
|------------------|---------------------------|----------------|-------------------|-----|---|-----|------|
| | | | MIN | MAX | SN74AI MIN | MAX | |
| ^t PLH | A B C D E E C or H | V | 3 | 15 | 3 | 10 | no |
| ^t PHL | A, B, C, D, E, F, G, or H | 1 | 3 | 15 | 3 | 12 | ns |

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

| Supply voltage, V _{CC} | 7 V |
|---|----------------|
| Input voltage, V _I | 7 V |
| Operating free-air temperature range, T _A : SN54AS30 | -55°C to 125°C |
| SN74AS30 | 0°C to 70°C |
| Storage temperature range | -65°C to 150°C |

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

| | | SN54AS30 | | | S | UNIT | | |
|----------|--------------------------------|----------|-----|-----|-----|------|-----|------|
| | | MIN | NOM | MAX | MIN | NOM | MAX | UNIT |
| VCC | Supply voltage | 4.5 | 5 | 5.5 | 4.5 | 5 | 5.5 | V |
| VIH | High-level input voltage | 2 | | | 2 | | | V |
| V_{IL} | Low-level input voltage | | | 0.8 | | | 0.8 | V |
| lOH | High-level output current | | | -2 | | | -2 | mA |
| lOL | Low-level output current | | | 20 | | | 20 | mA |
| TA | Operating free-air temperature | -55 | | 125 | 0 | | 70 | °C |

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| DADAMETED | TEST C | TEST CONDITIONS | | SN54AS30 | | | SN74AS30 | | |
|-----------------|---|--------------------------|------|----------|------|--------------------|----------|------|------|
| PARAMETER | TEST C | | | TYP§ | MAX | MIN | TYP§ | MAX | UNIT |
| VIK | $V_{CC} = 4.5 \text{ V},$ | I _I = -18 mA | | | -1.2 | | | -1.2 | V |
| Voн | $V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$ | $I_{OH} = -2 \text{ mA}$ | Vcc- | 2 | | V _{CC} -2 | 2 | | V |
| V _{OL} | $V_{CC} = 4.5 V,$ | $I_{OL} = 20 \text{ mA}$ | | 0.35 | 0.5 | | 0.35 | 0.5 | V |
| lį | $V_{CC} = 5.5 V,$ | V _I = 7 V | | | 0.1 | | | 0.1 | mA |
| lіН | $V_{CC} = 5.5 \text{ V},$ | V _I = 2.7 V | | | 20 | | | 20 | μΑ |
| I _{IL} | $V_{CC} = 5.5 V,$ | V _I = 0.4 V | | | -0.5 | | | -0.5 | mA |
| ΙΟ [¶] | $V_{CC} = 5.5 V,$ | V _O = 2.25 V | -30 | | -112 | -30 | | -112 | mA |
| Iссн | V _{CC} = 5.5 V, | V _I = 0 | | 0.9 | 1.5 | | 0.9 | 1.5 | mA |
| ICCL | V _{CC} = 5.5 V, | V _I = 4.5 V | | 3 | 4.9 | | 3 | 4.9 | mA |

[§] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.



The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

SN54ALS30A, SN54AS30, SN74ALS30A, SN74AS30 8-INPUT POSITIVE-NAND GATES

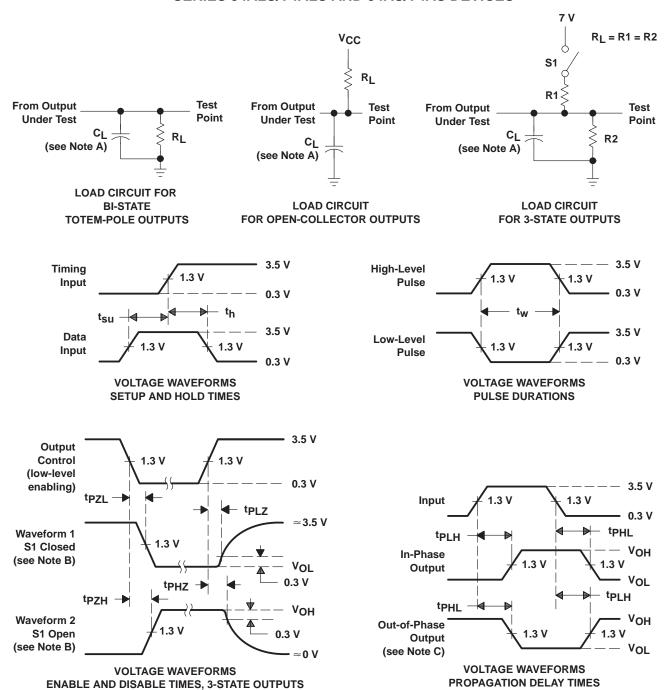
SDAS010B - MARCH 1984 - REVISED DECEMBER 1994

switching characteristics (see Figure 1)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | C _L R _L | = 50 pF = 500 £ = MIN t | | | UNIT |
|------------------|---------------------------|----------------|----------------------------------|-------------------------------|-----|-----|------|
| | | | MIN | MAX | MIN | MAX | |
| t _{PLH} | A, B, C, D, E, F, G, or H | V | 1 | 5.5 | 1 | 5 | ns |
| t _{PHL} | A, B, C, D, E, F, G, OI H | Ť | 1 | 5 | 1 | 4.5 | 115 |

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- D. All input pulses have the following characteristics: PRR \leq 1 MHz, $t_r = t_f = 2$ ns, duty cycle = 50%.
- E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms



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